## Search Notes



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#### Examiner

Nguyen, Lauren Nguyen, Lauren

# Applicant(s)/Patent Under Reexamination

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28712871

#### **SEARCHED**

| Class | Subclass    | Date       | Examiner |
|-------|-------------|------------|----------|
| 349   | 15, 201-202 | 04/03/2007 | LN       |
| 359   | 376, 462    | 04/03/2007 | LN       |

#### **SEARCH NOTES**

| Search Notes                                | Date       | Examiner |
|---|------------|----------|
| Consulted Primary Examiner Andrew Schechter | 04/03/2007 | LN       |

### INTERFERENCE SEARCH

| Class | Subclass | Date | Examiner |
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